

## IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

## **CB TEST CERTIFICATE**

**Product** 

Name and address of the applicant

Name and address of the manufacturer

Name and address of the factory

Note: When more than one factory, please report on page 2

Ratings and principal characteristics

Trademark / Brand (if any)

Customer's Testing Facility (CTF) Stage used

Model / Type Ref.

Additional information (if necessary may also be reported on page 2)

A sample of the product was tested and found to be in conformity with

As shown in the Test Report Ref. No. which forms part of this Certificate

Component IC Current Limiter

Texas Instruments Incorporated 12500 TI Boulevard, Dallas, TX 75243 United States of America

Texas Instruments Incorporated 12500 TI Boulevard, Dallas, TX 75243 United States of America

TEXAS INSTRUMENTS DE MEXICO S DE R L DE C V JESUS RIVERA FRANCO # 507 CD INDUSTRIAL 20290 AGUASCALIENTES AGS Mexico

X Additional information on page 2

TPS25980/TPS25982: Input Voltage: 2.7 – 24.0 Vdc Output Continuous Rating: 1.53 A Output Current Limit: 2.43 A Continuous Switch Current: 8/15 A Maximum Ambient: 105°C

TPS25983: Input Voltage: 2.7 – 26.0 Vdc Output Continuous Rating: 1.53 A Output Current Limit: 2.43 A Continuous Switch Current: 20 A Maximum Ambient: 105°C



Models TPS25982, TPS25980, TPS25983 f/b 2,3,4 or 7, f/b L or O, may be followed by additional characters that do not affect the safety features of the device.

☐ Additional information on page 2

IEC 62368-1:2018

National differences:

 $\mathsf{AU},\,\mathsf{CA},\,\mathsf{DK},\,\mathsf{FI},\,\mathsf{IE},\,\mathsf{IT},\,\mathsf{JP},\,\mathsf{NO},\,\mathsf{NZ},\,\mathsf{SA},\,\mathsf{SE},\,\mathsf{SG},\,\mathsf{US}$ 

US-2901-MET EN 135210 M0A0

This CB Test Certificate is issued by the National Certification Body

Eurofins Electrical and Electronic Testing NA, LLC 914 W Patapsco Avenue Baltimore, , MD 21230 United States of America



E&E

Date: 2025-07-02 Signature: Hon Keung Ip





## Additional factory

TEXAS INSTRUMENTS SEMICONDUCTOR MANUFACTURING (CHENGDU) CO., LTD.

NO. 8-8 & NO.8-10, KEXIN RD WEST ZONE OF CHENGDU HI-TECH INDUSTRIAL DEVELOPMEN CHENGDU, SICHUAN

TEXAS INSTRUMENTS TAIWAN LTD

142 HSIN NAN RD, SEC 1CHUNG HO, TAIPEI HSIEN, 235

China

ASE ASSEMBLY & TEST (SHANGHAI) LTD

#669 GUOSHOUJING RD ZHANGJIANG HI-TECH PARK, PUDONG WELGROW INDUSTRIAL ESTATE, 73 MOO5 BANGNA-TRAD (KM
NEW AREA SHANGHAI 201203

38) RDA BANGPAKONG, T BANGSAMAK, CHACHOENGSAO

Thailand

TONGFU MICROELECTRONICS CO LTD

NO. 288, CHONGCHUAN RD, CHONGCHUAN DEVELOPMENT ZONE, NANTONG JIANGSU 226006

China

TEXAS INSTRUMENTS MALAYSIA SDN BHD

1 LORONG ENGGANG 33, AMPANG/ULU KLANG, 54200 KUALA

**LUMPUR** Malaysia

HANA MICROELECTRONICS CO LTD (JIA XING)
18 HANA RD XINCHENG INDUSTRIAL PARK XIUZHOU DISTRICT
18 HANA RD XINCHENG INDUSTRIAL PARK XIUZHOU DISTRICT
18 HANA RD XINCHENG 31400
19 PARK XIUZHOU DISTRICT
19 PARK XIUZHOU DISTRICT
10 PHILIPPINES) INC
10 CLARK TI SPECIAL ECONOMIC ZONE CLARK FREEPORT, ZONE
ANGELES PAMPANGA

Philippines

HANA SEMICONDUCTOR (AYUTTHAYA) CO LTD HI-TECH IND ESTATE AUTH OF THAILAND, 100 MOO1, T BAAN-

LEN, A BANG PA-IN, KM 59 ASIA RD AYUTTHAYA 13160

CARSEM SEMICONDUCTOR CO LTD

NO 88 WEST SHEN HU ROAD IN DISTRICT 2 SUZHOU

INDUSTRIAL PARK JIANGSU 215021

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